

AOD422

20V N-Channel MOSFET

General Description

The AOD422 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 1.8V. This device is suitable for use as a load switch or in PWM applications. It is ESD protected.

Product Summary

20V V_{DS} I_D (at V_{GS} =4.5V) 20A $R_{DS(ON)}$ (at V_{GS} =4.5V) < 25m Ω $R_{DS(ON)}$ (at $V_{GS} = 2.5V$) < 28m Ω $R_{DS(ON)}$ (at $V_{GS} = 1.8V$) < 34m Ω

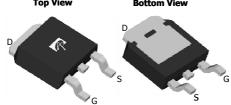
ESD protected 100% UIS Tested

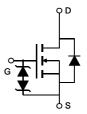












Absolute Maximum Ratings $T_A=25$ °C unless otherwise noted

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	20	V	
Gate-Source Voltage		V _{GS}	±8	V	
Continuous Drain T _C =25℃		1	20		
Current ^G	T _C =100℃	'D	16	A	
Pulsed Drain Current ^C		I _{DM}	90		
Continuous Drain	T _A =25℃		8	A	
Current	T _A =70℃	IDSM	6.5	^	
Avalanche Current ^C		I _{AS} , I _{AR}	15	A	
Avalanche energy L=0.1mH ^C		E _{AS} , E _{AR}	11	mJ	
	T _C =25℃	В	37	W	
Power Dissipation ^B	T _C =100℃	P _D	18	VV	
	T _A =25℃	Prov	2.5	10/	
Power Dissipation A	T _A =70℃	P _{DSM}	1.6	W	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 175	C	

Thermal Characteristics							
Parameter	Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient A	t ≤ 10s		16.7	25	€/M		
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	40	50	€/M		
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	3	4	€\M		



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		20			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =20V, V _{GS} =0V				1	
			T _J =55℃			5	μΑ
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±4.5V				±1	uA
		V_{DS} =0V, V_{GS} = ±8V				±10	uA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$		0.4	0.7	1.1	V
$I_{D(ON)}$	On state drain current	V _{GS} =4.5V, V _{DS} =5V		45			Α
	Static Drain-Source On-Resistance	V_{GS} =4.5V, I_{D} =10A			16	25	mΩ
R _{DS(ON)}			T _J =125℃		22	31	11152
		V _{GS} =2.5V, I _D =8A			18	28	mΩ
		V_{GS} =1.8V, I_{D} =5A		21	34	mΩ	
g _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =10A		55		S	
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.62	1	V	
Is	Maximum Body-Diode Continuous Current					20	Α
	PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =10V, f=1MHz		1035	1295	1650	pF
C _{oss}	Output Capacitance			110	160	210	pF
C_{rss}	Reverse Transfer Capacitance			50	87	125	pF
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz		0.9	1.8	2.7	ΚΩ
SWITCHI	NG PARAMETERS						
Q_g	Total Gate Charge	V _{GS} =4.5V, V _{DS} =10V, I _D =10A			10		nC
Q_{gs}	Gate Source Charge				4.2		nC
Q_{gd}	Gate Drain Charge				2.6		nC
t _{D(on)}	Turn-On DelayTime	V_{GS} =10V, V_{DS} =10V, R_L =1 Ω , R_{GEN} =3 Ω			280		ns
t _r	Turn-On Rise Time				328		ns
$t_{D(off)}$	Turn-Off DelayTime				3.76		us
t _f	Turn-Off Fall Time				2.24		us
t _{rr}	Body Diode Reverse Recovery Time	I_F =10A, dI/dt=500A/ μ s, V_{GS} =-9V			25		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =10A, dI/dt=500A/μs	s, V _{GS} =-9V		75		nC

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R $_{\theta JA}$ and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =175° C. Ratings are based on low frequency and duty cycles to keep initial T_J =25° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

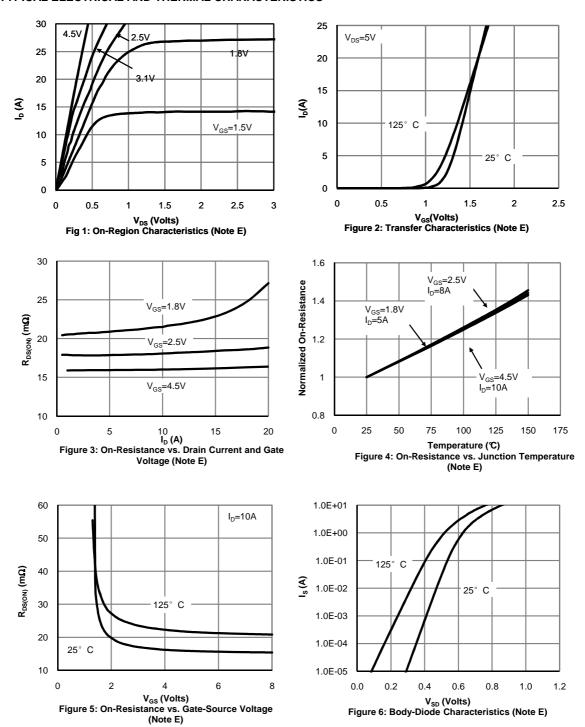
F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =175° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

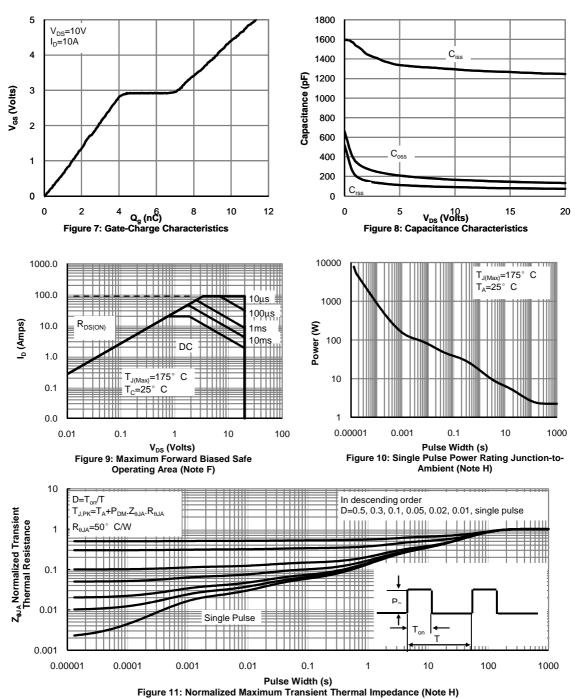


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



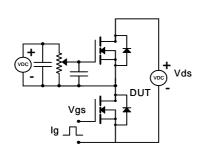


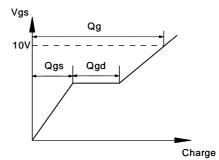
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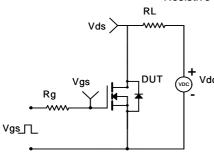


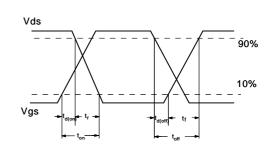
Gate Charge Test Circuit & Waveform



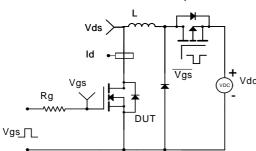


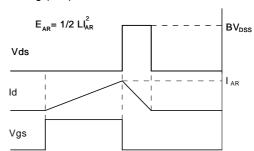
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

